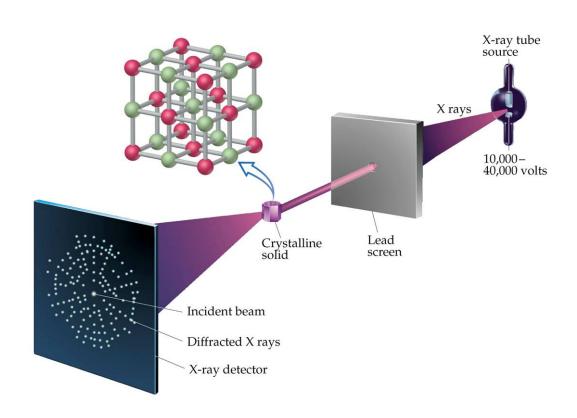
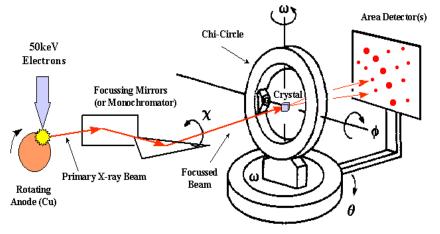
La diffraction des rayons X

où comment retouver la position de 10²³ atomes à partir d'un petit nombre de paramètres?

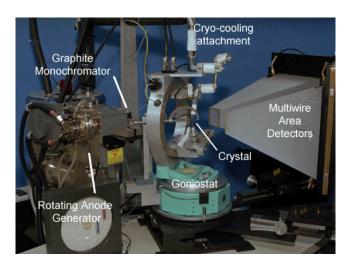


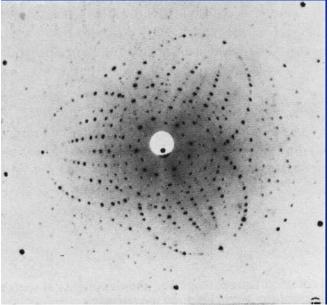
Structure des protéines

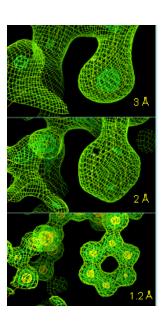


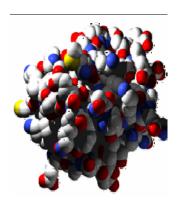






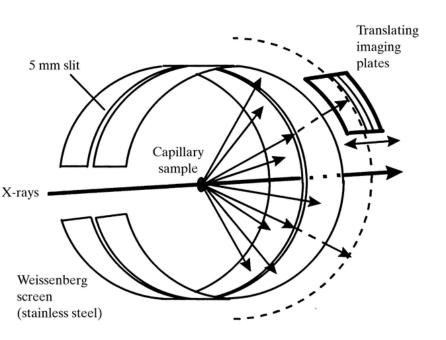


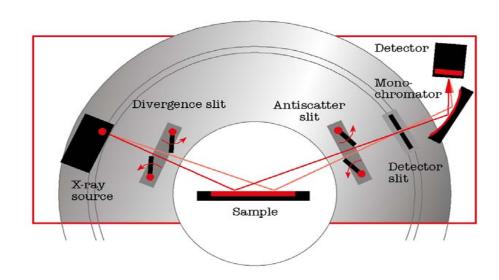


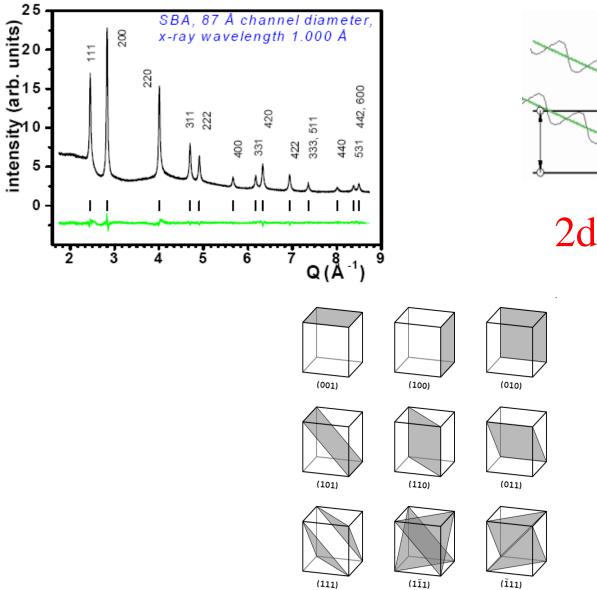


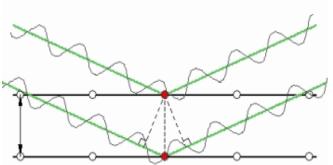
Debye Scherrer

Bragg-Brentano









 $2d_{(hkl)}sin\theta = n\lambda$

$$I_{hkl} \propto m L(\theta) P(\theta) |F_{hkl}|^2$$

m : multiplicité = nb de plans équivalents

	Table 3.3. Plane Multiplicity Factors, M_{bkl}										
System	hkl	hhl	hh0	0kk	hhh	hk0	hOl	0kl	h00	0k0	001
Cubic	48ª	24	12	(12)	8	24ª	(24a)	(24a)	6	(6)	(6)
Tetragonal	16^{a}	8	4	(8)	(8)	8^a	8	(8)	4	(4)	2
Hexagonal	24^{a}	12^a	6	(12)	(12)	12^{a}	(12^a)	12^{a}	6	(6)	2
Orthorhombic	8	(8)	(8)	(8)	(8)	4	(4)	(4)	2	(2)	(2)
Monoclinic	4	(4)	(4)	(4)	(4)	(4)	(2)	(4)	2	(2)	(2)
Triclinic	2	(2)	(2)	(2)	(2)	(2)	(2)	(2)	(2)	(2)	(2)

[&]quot;When all permutations of indices do not produce equivalent planes, M must be reduced by half.

P facteur de polarisation (diffusion thomson) - pour une onde non polarisée

$$P(\theta) = \frac{1 + (\cos(2\theta))^2}{2}$$

L facteur de Lorentz (dépend de la géométrie de l'expérience : intersection entre la sphere d'Ewald et le réseau réciproque)

$$L(\theta) = \frac{1}{\sin^2(\theta)\cos(\theta)}$$

$$ert F_{\mathit{hkl}}$$
facteur de structure

$$F_{hkl} = \sum_{i} f_{i} e^{2i\pi(hx_{j} + ky_{j} + lz_{j})}$$

coefficient de diffusion atomique

Where B, the Debye-Waller temperature factor is:

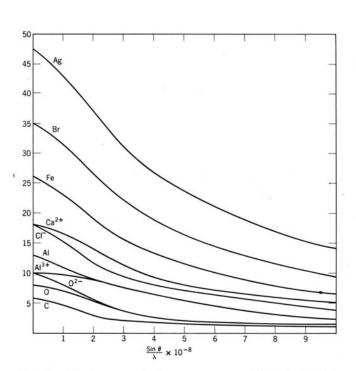


Fig. 3-15. Diffracting power of a few common atoms and ions (after C. W. Bunn, Chemical Crystallography, Oxford University Press, 1945).

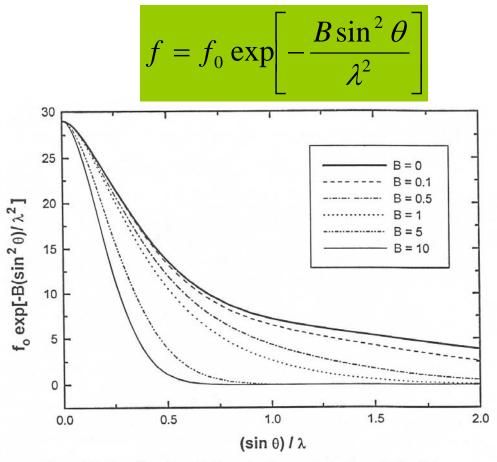
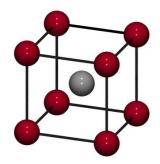


Figure 3.14. The effect of atomic thermal motion on the copper scattering factor.



Extinctions systématiques

$$F_{hkl} = \sum_{j} f_{i} e^{2i\pi(hx_{j} + ky_{j} + lz_{j})}$$

For example, for a body-centered

cubic cell, for each atom located at x, y, z there will be an identical atom located at $x+\frac{1}{2}$, $y+\frac{1}{2}$, $z+\frac{1}{2}$. The structure factor \mathbf{F}_{hkl} is represented by the following equation.

$$\mathbf{F}_{hkl} = \left(\sum_{j=1}^{m/2} f_n \exp\left[2\pi i(hx_j + ky_j + lz_j)\right] + \left(\sum_{n=1}^{m/2} f_n \exp\left[2\pi i(hx_j + \frac{h}{2} + ky_j + \frac{k}{2} + lz_j + \frac{l}{2}\right]\right)$$

While complicated, it is noted that if h + k + l is even, then the second term will contain an integer, n, in it. An integral number of 2π 's will have no effect on the value of this term and the equation reduces to:

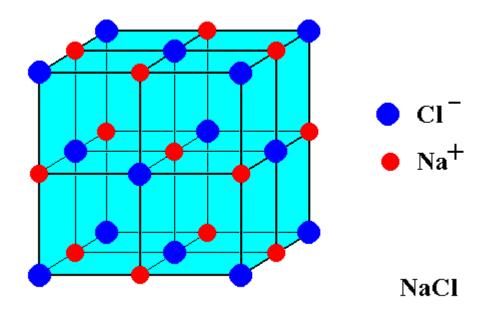
$$\mathbf{F}_{hkl} = \sum_{j=1}^{m/2} 2f_n \exp\left[2\pi i(hx_j + ky_j + lz_j)\right]$$

If h + k + l is odd, however, the second term will contain an integer with a $2\pi(n/2)$ term; here n is any integer and represents a full rotation of the scattering vector. This causes the second term to be negative, and the net result is there is no diffracted intensity (since $\mathbf{F}_{hkl} = 0$). This condition is called a *systematic extinction*. The table below lists the systematic extinction conditions due to translational symmetry elements¹:

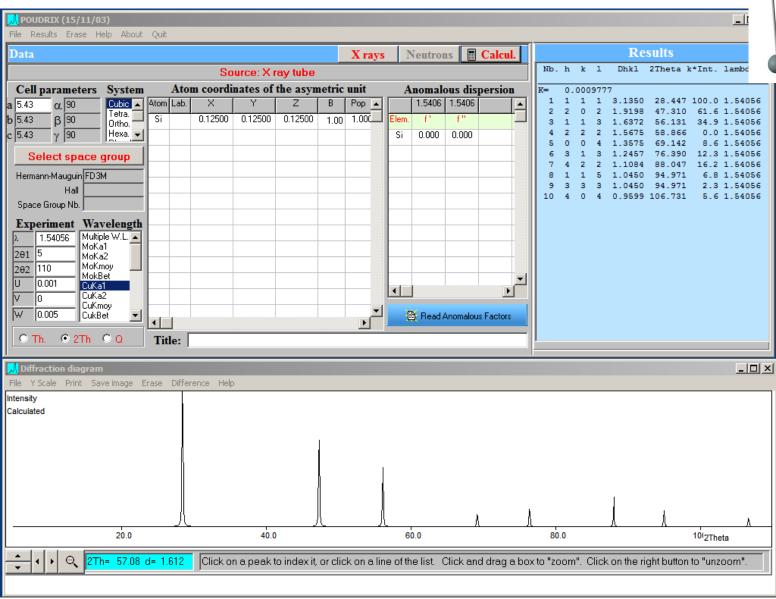
Symmetry	Extinction Conditions					
P	none					
C	hkl; $h + k = oddhkl$; $h + l = oddhkl$; $k + l = oddhkl$; $h + k + l = odd$					
B	hkl; h + l = odd					
A	hkl; k+l = odd					
I	hkl; h+k+l = odd					
F	hkl; h, k, l mixed even and odd					
$2_1 \parallel b$	0k0: k = odd					

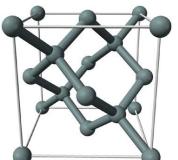
P = primitive lattice; C, B, A = side-centered on c-, b-, a-face; I = body centered; F = face centered (001)

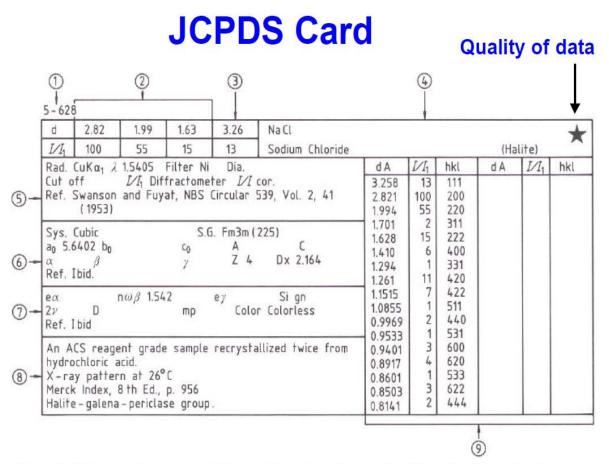
question: KCI et NaCI adoptent la même structure (NaCI). Pourtant, le diagramme de diffraction de KCI est plus proche d'un cubique simple que d'un CFC – pourquoi?



simulation du diagramme de diffraction : poudrix (silicium)





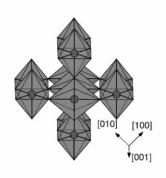


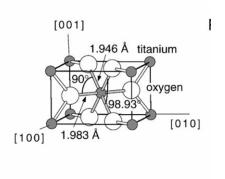
1.file number 2.three strongest lines 3.lowest-angle line 4.chemical formula and name 5.data on diffraction method used 6.crystallographic data 7.optical and other data 8.data on specimen 9.data on diffraction pattern.

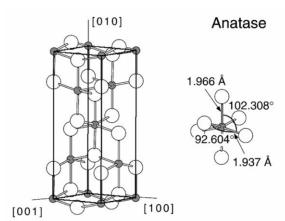
Joint Committee on Powder Diffraction Standards, JCPDS (1969) Replaced by International Centre for Diffraction Data, ICDF (1978)

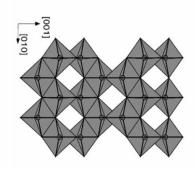
Oxyde de titane

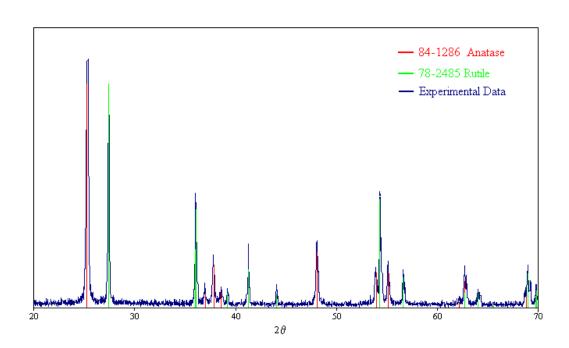
Rutile



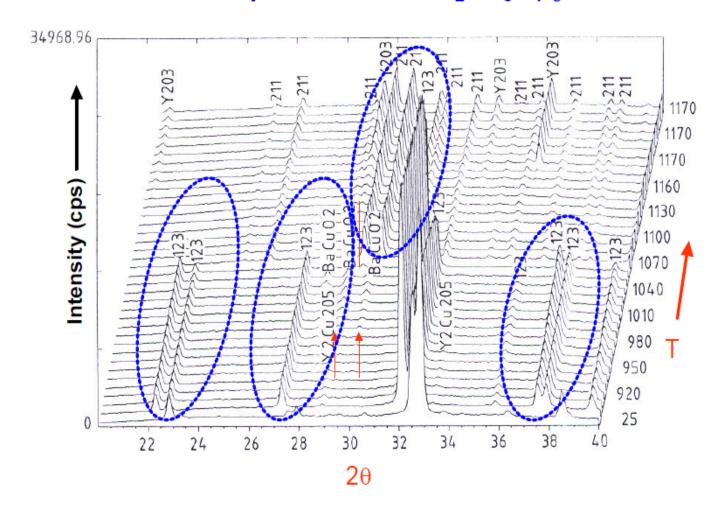




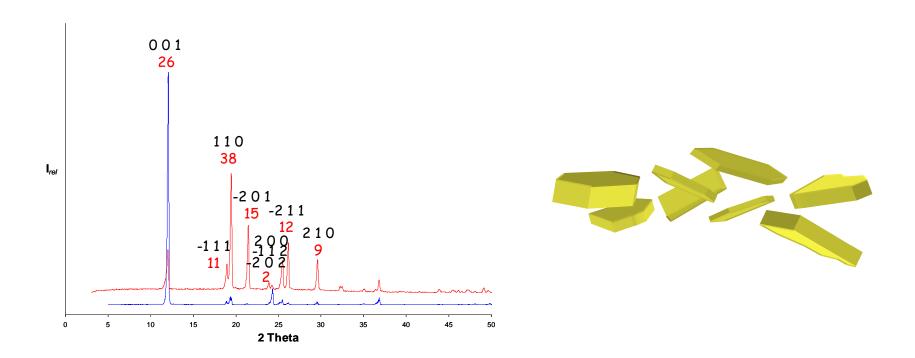




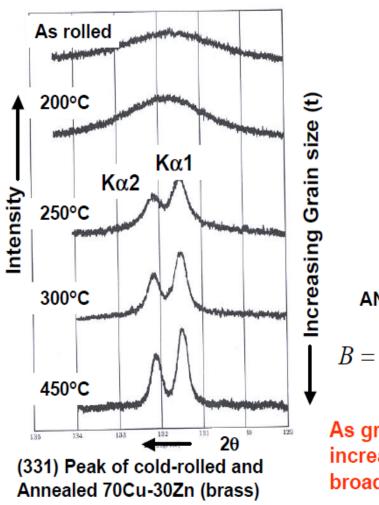
High Temperature XRD Patterns of the Decomposition of YBa₂Cu₃O_{7-δ}

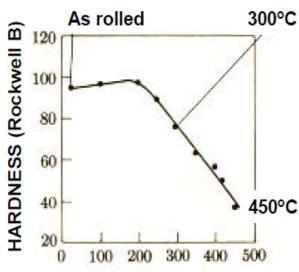


Effet de texturation



Effect of Coherent Domain Size





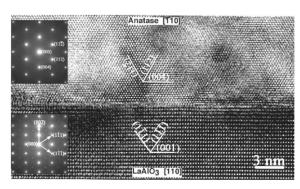
ANNEALING TEMPERATURE (°C)

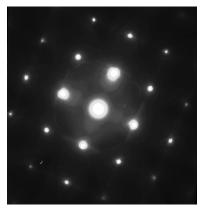
$$B = \frac{0.9 \cdot \lambda}{t \cdot Cos\theta}$$
 Peak Broadening Scherrer Model

As grain size decreases hardness increases and peaks become broader

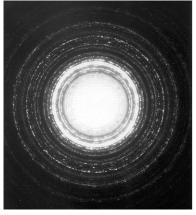
Diffraction électronique







monocristal

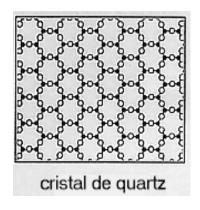


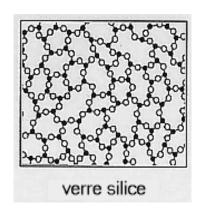
poudre

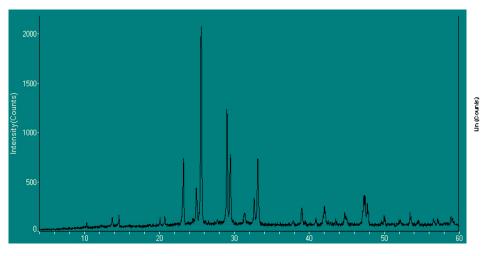


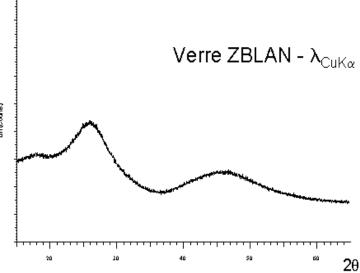
amorphe

diffraction des amorphes









fonction de distribution radiale

